

**Charge collection and crosstalk signals in ABCD3T  
(by Jan Kaplon)  
for SCT crosstalk study**

24 August, 2010

SCT Digitization TF meeting

Taka Kondo (KEK)  
on behalf of Jan Kaplon (CERN)

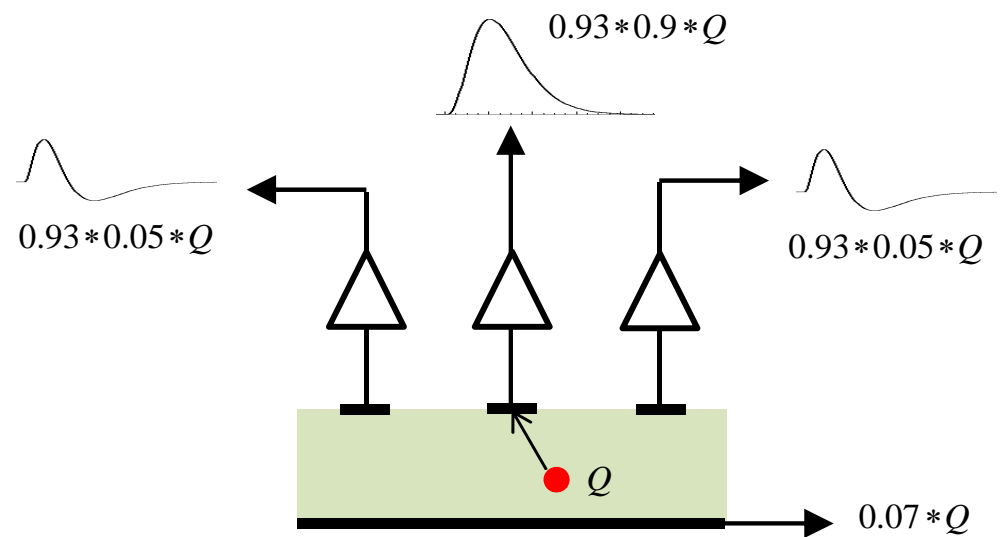
## Present SCT digitization model

- (1) 7% of the hole charge is absorbed by the HV plane.
- (2) 5% (10% total) of the hole charge is absorbed by the adjacent strip.
- (3) The main signal has a shape:

$$a(t) = C_1(t/\tau)^3 e^{-t/\tau}$$

- (4) The crosstalk pulse is a differential form of the main signal

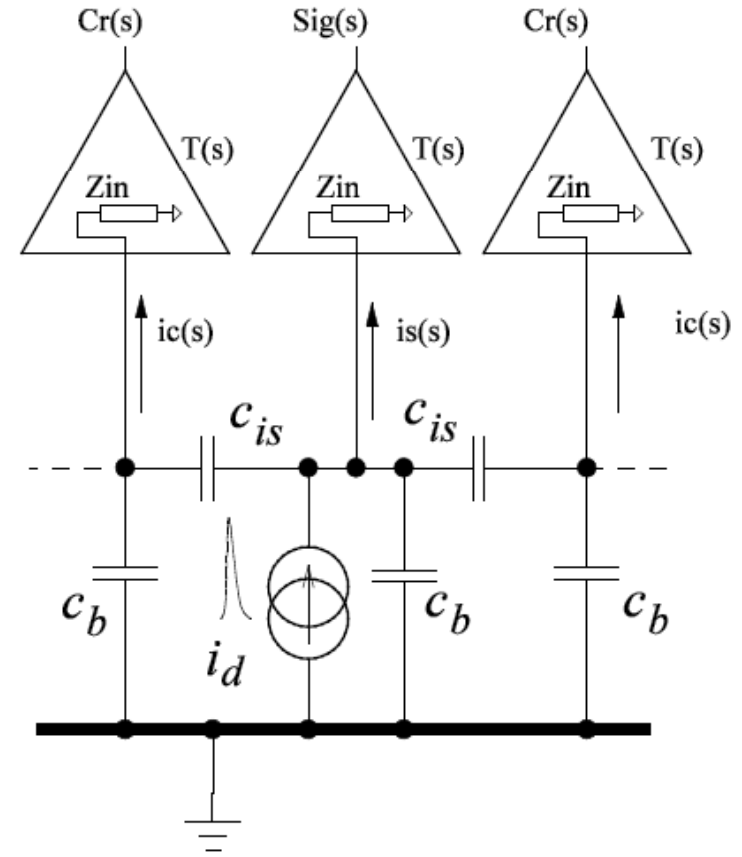
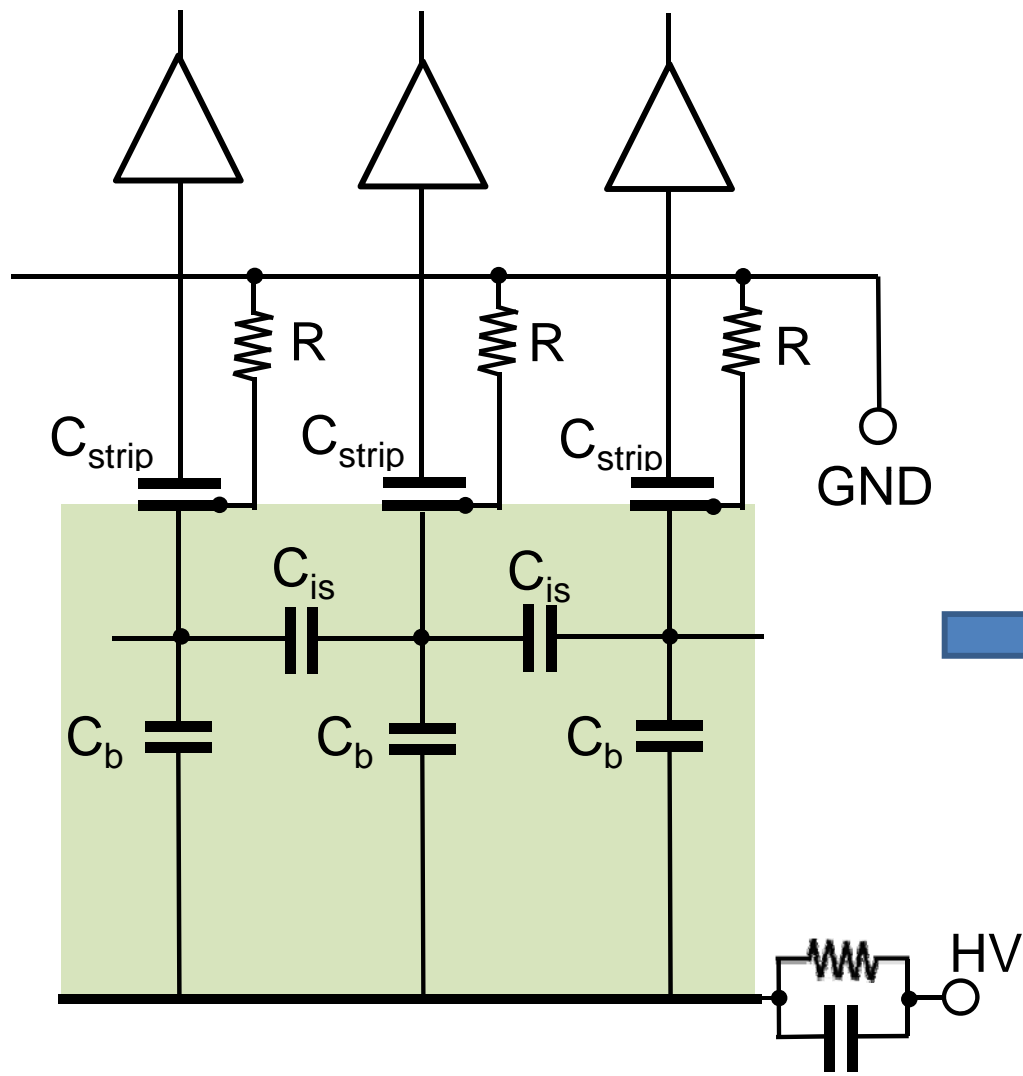
$$b(t) = C_2(t/\tau)^2 e^{-t/\tau} (3 - t/\tau)$$



Studies so far indicated that the **<cluster size><sub>average</sub>** is sensitive to the **level and shape of the crosstalk**.

Jan Kaplon (CERN) kindly worked on the input impedance of the ABCD chips, the key electrical parameter for crosstalk.

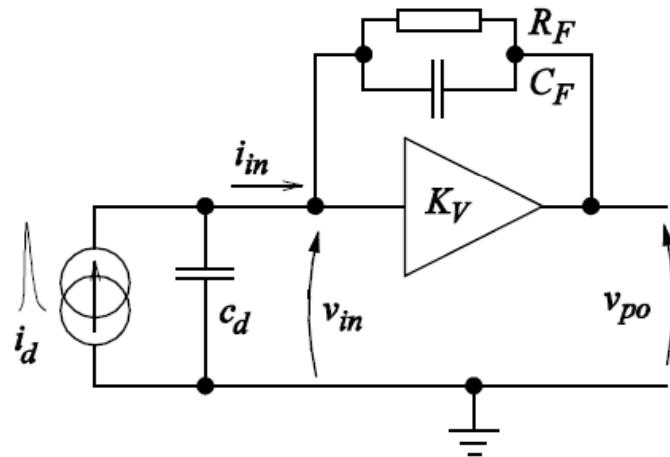
# ABCD chips: Electrical parameters [1]



Kaplon's circuit model:  
neglecting  $C_{strip}$  and  $R$

[1] F. Campabadal et al., NIMA 552 (2005) 292

# ABCD input impedance model



In operator domain:

Considering dominant pole only the open loop gain is:

$$K_V(s) = \frac{K_V}{1 + s \cdot \tau_{P0}}$$

And the input impedance in operator domain:

$$Z_{in}(s) = \frac{Z_F(s)}{1 + K_V(s)} \approx \frac{Z_F(s)}{K_V(s)} = \frac{R_F \cdot (1 + s \cdot \tau_{P0})}{K_V \cdot (1 + s \cdot \tau_f)}$$

For ABCD3T preamplifier:

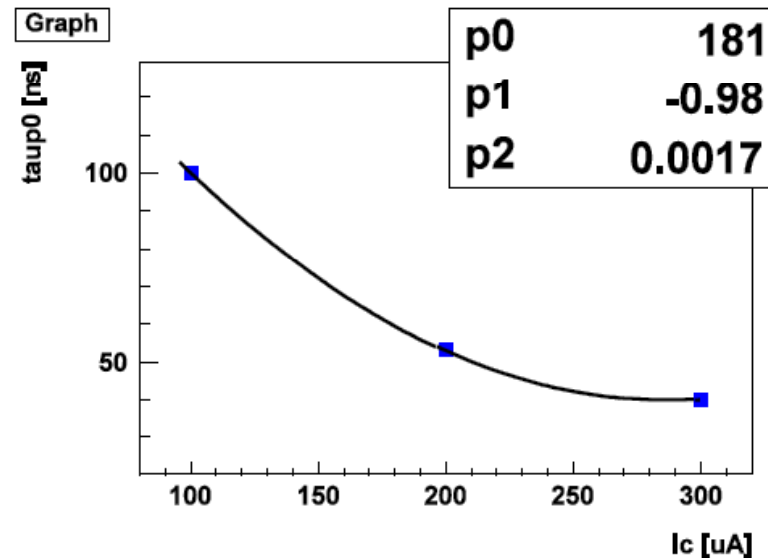
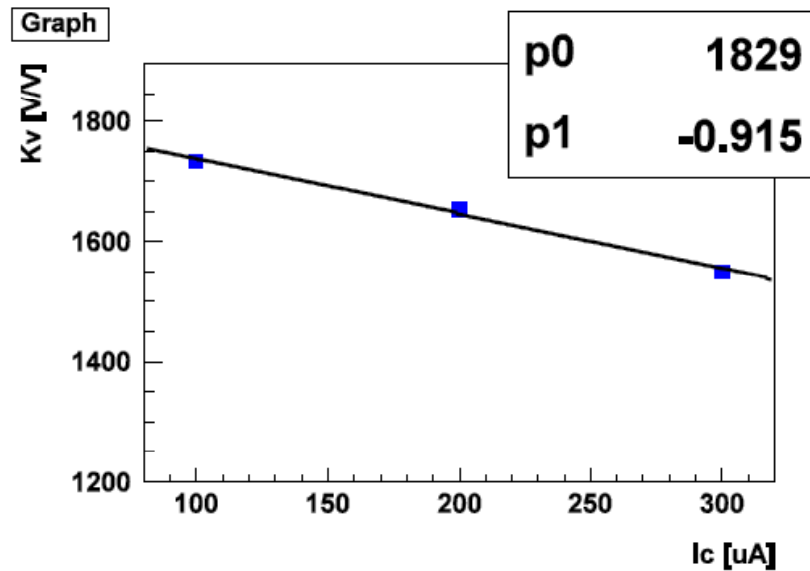
$R_f = 80k$ ,  $C_f = 120fF \rightarrow \tau_f = 10ns$

The  $K_v$  and  $\tau_{p0}$  we obtain from AC Spice simulation for a given input transistor bias  $I_c$

$I_c$	100uA	200uA	300uA
$\tau_{p0}$ [ns]	100	53	40
$K_v$ [V/V]	1733	1654	1550

For intermediate values of bias current one should use interpolation function

# ABCD input impedance model



For  $I_C$  values from 100 to 300uA range one can approximate the  $\tau_{p0}$  and  $K_V$  as following:

$$\tau_{p0} = 181 - 0.98 \cdot I_C + 0.0017 \cdot I_C^2$$

$$K_V = 1829 - 0.915 \cdot I_C$$

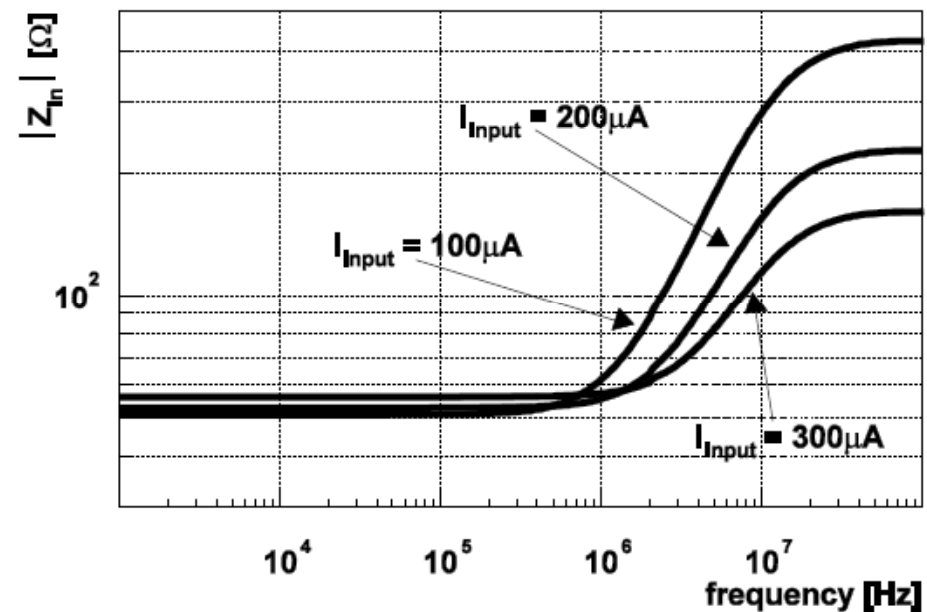
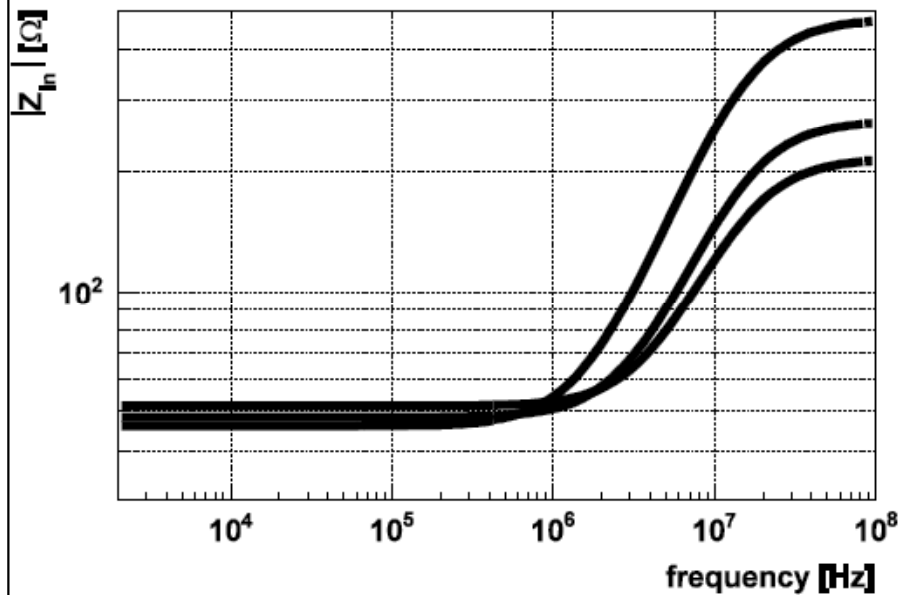
where  $I_C$  in uA,  $\tau_{p0}$  in ns, and  $K_V$  in [V/V]

# ABCD input impedance model

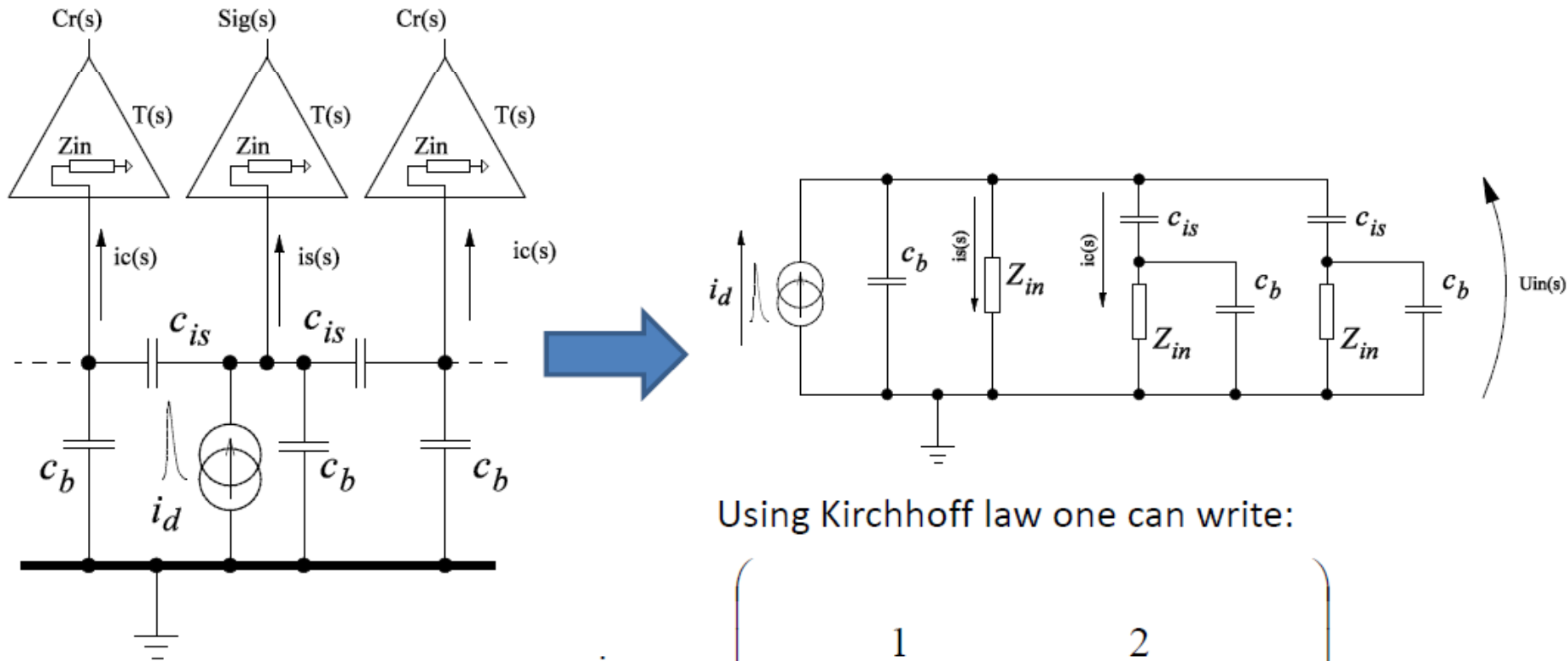
In frequency domain the  $Z_{in}$  is following :

$$|Z_{in}| = \frac{R_F}{K_V} \cdot \frac{\sqrt{1 + \omega^2 \cdot \tau_{P0}^2}}{\sqrt{1 + \omega^2 \cdot \tau_f^2}}$$

This simple model using extracted parameters  $K_V$  and  $\tau_{P0}$  (left figure) can be verified with the Spice simulation of the ABCD3T input impedance (right) for the same input transistor bias currents



# Currents at front end inputs



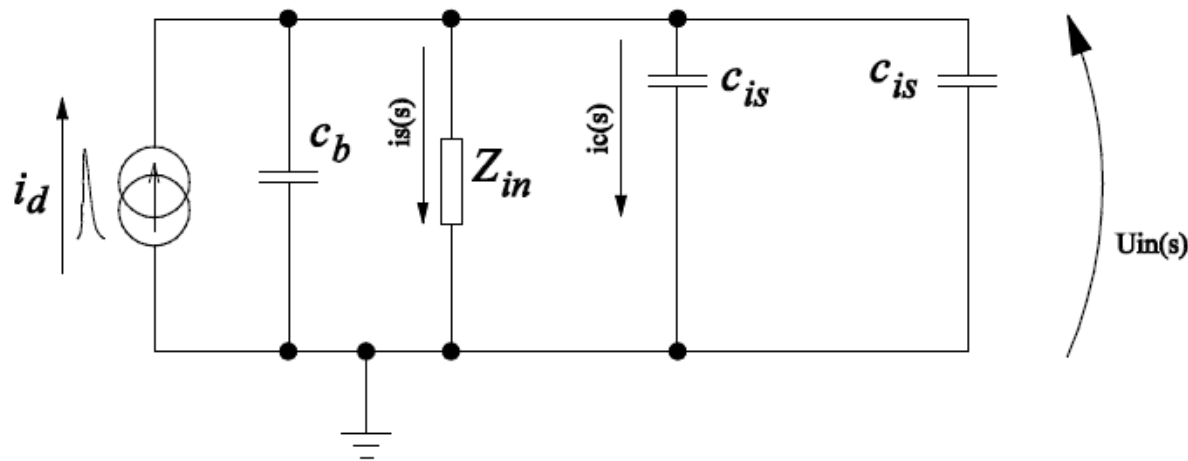
Using Kirchoff law one can write:

$$i_d = u_{in} \cdot \left( s \cdot c_b + \frac{1}{Z_{in}} + \frac{2}{\frac{1}{s \cdot c_{is}} + \frac{Z_{in}}{s \cdot c_b \cdot Z_{in} + 1}} \right)$$

Unfortunately the use of this expression gives problems later during calculation of inverse Laplace functions. We have to simplify the model.

# Currents at front end inputs

A reasonable trade off between accuracy and simplicity is shown below:



In this case we assume that input of the preamplifier is loaded with  $c_b$  and two  $c_{is}$  capacitances (neglecting input impedances of the neighbors). Using Kirchhoff law one can write:

$$i_d = u_{in} \cdot \left( s \cdot (c_b + 2 \cdot c_{is}) + \frac{1}{Z_{in}} \right)$$

Since we assume delta Dirac input we can write expression for voltage at the preamplifier input:

$$u_{in} = \frac{Z_{in}}{1 + s \cdot (c_b + 2 \cdot c_{is}) \cdot Z_{in}}$$



# Currents at front end inputs

Expressions for current flowing into the input of readout channel:

$$i_s = u_{in} \cdot \frac{1}{Z_{in}}$$

For the expression of current flowing into neighboring channel we use simplified expression for  $u_{in}$  and expression for input impedance of neighboring channel connected in series with  $c_{is}$  capacitance (neglecting  $c_b$ ):

$$i_c = u_{in} \cdot \frac{1}{Z_{in} + \frac{1}{s \cdot c_{is}}}$$

by J. Kaplon

# Currents at front end inputs; what is happening to signal charge

Current flowing into the input of neighboring channels and backplane capacitance:

$$i_{lost} = u_{in} \cdot s \cdot (c_b + 2 \cdot c_{is})$$

One should note that the overall charge transfer to readout channel is full i.e.

$$\int_0^{\infty} i_s(t) dt = 1 \quad \text{and} \quad \int_0^{\infty} i_{lost}(t) dt = 0$$

That means that after some delay caused by  $Z_{in}$  all charge flows finally into the input of preamplifier connected to the hit strip i.e. we do not see the loss of charge however the response of the preamplifier stage is generally slower due to extra time constant created by  $Z_{in}$  and detector capacitance (detector time constant).

In general the detector time constant modifies the preamplifier transfer function changing the gain, peaking time and phase margin. All those changes and possible loss of signal at the end of the full signal processing chain will depend on detector time constant and time constants of all stages contributing to the signal formation.

N.B. This applies to transimpedance preamplifiers, where the input impedance has real part. In case of pure charge preamplifier with non-continuous reset (reset switch) there will be real charge sharing in between all capacitances at the preamplifier input during the readout phase.

# ABCD transfer function and responses to signal and crosstalk

Overall transfer function of ABCD3T channel can be approximated with CR-RC response of preamplifier with time constant of  $\tau_f = 10\text{ns}$  and two stages of integrators with time constant  $\tau_i = 4\text{ns}$

$$T_{ABCD} = \frac{\tau_f}{(1 + s \cdot \tau_f)^2} \frac{1}{(1 + s \cdot \tau_i)^2}$$

The response of ABCD to delta Dirac function in time domain will be:

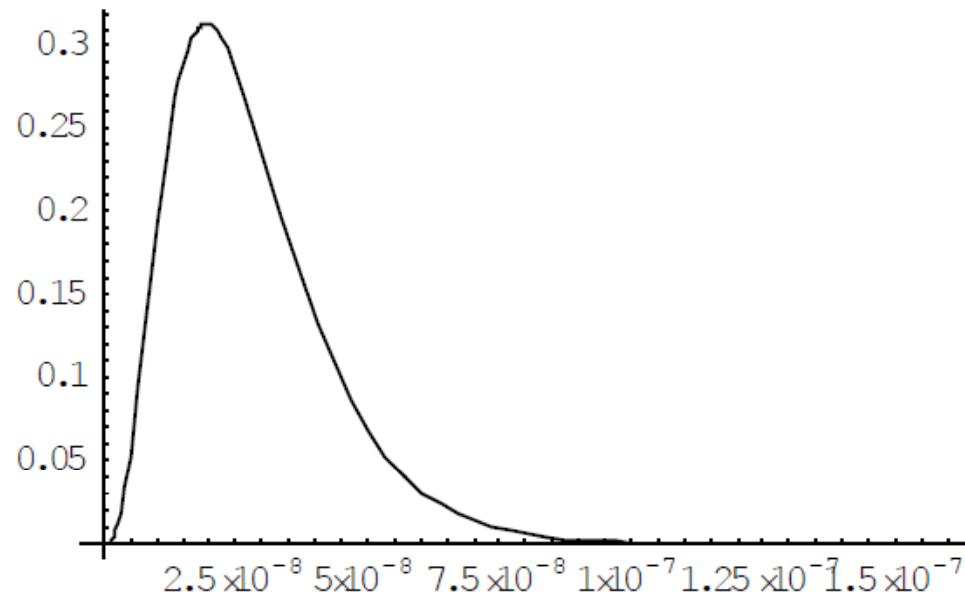
$$L^{-1}(T_{ABCD} \cdot i_s)$$

The crosstalk of first neighbor in time domain will be:

$$L^{-1}(T_{ABCD} \cdot i_c)$$

# Example of calculation

$K_v$  and  $\tau_{p0}$  for  $I_c=200\mu A$  (table page 1)

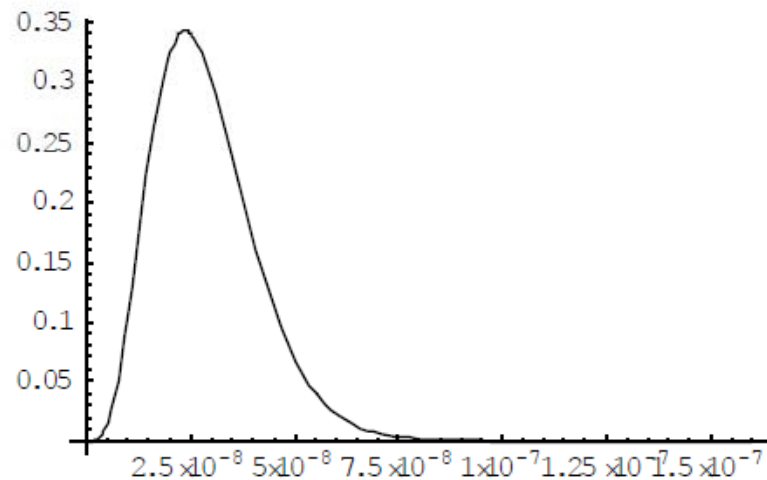


Response for channel not loaded with detector

Max=0.313349 for  $t=19.4366\text{ns}$

# Example of calculation

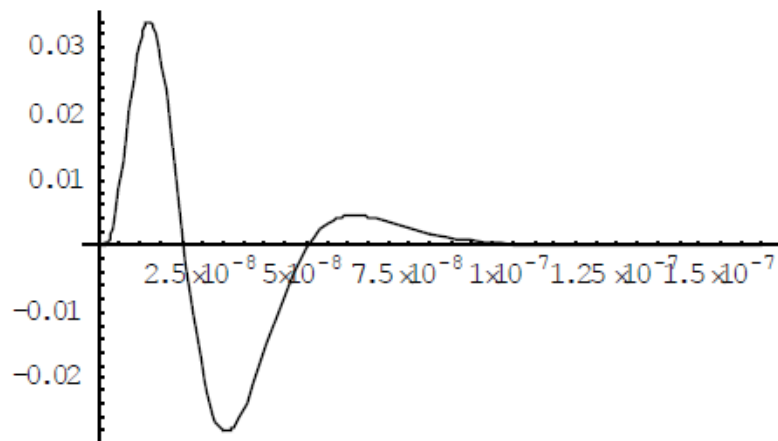
$K_v$  and  $\tau_{p0}$  for  $I_c=200\mu A$  (table page 1),  $c_b=4pF$ ,  $c_{is}=7pF$



Response for channel loaded with detector

Max=0.34299 for  $t=23.7339\text{ns}$

When compare to response of the open channel (previous page) we can see that the peaking time has been changed from 19.4ns to 23.7ns and the peak gain has been increased from 0.313 to 0.343. The change of gain and peaking time is caused by detector time constant which change the overall response of the preamplifier (modifying also the phase margin).



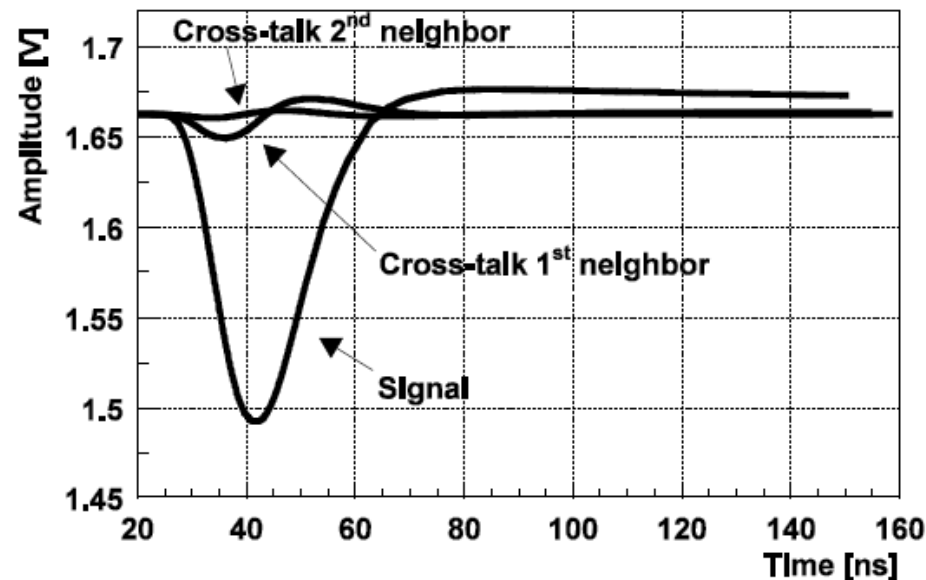
Crosstalk

Max=0.0339311 for  $t=12.012\text{ns}$

# Comparison of analytical model to Spice simulations

Crosstalk for  $c_{is}=7\text{pF}$  and  $c_b=4\text{pF}$  and  $I_c=200\mu\text{A}$  calculated using presented formulas is in the range of 10%.

Crosstalk simulated in Spice for the same detector and front end parameters is in the range of 8% (see figure below). The overestimation of the crosstalk can be both to analytical model inaccuracy as well as to the fact that in the Spice we have used longer charge collection times (8ns) when in calculation we use as the detector signals delta Dirac function.



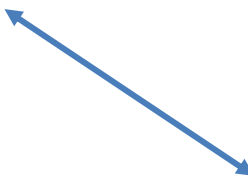
## Summary of Jan Kaplon's work

1. Using the Laplace transformation of the equivalent circuit (with some simplifications) and the inverse-Laplace transfer function of Mathematica, analytic expressions of the signal and crosstalk are obtained.
2. With  $C_b=4\text{pf}$ ,  $C_{is}=7\text{pF}$  and  $I_C=200\text{ uA}$ , the crosstalk level for delta-function input is

$$\frac{\textit{peak}_{crosstalk}}{\textit{peak}_{signal}} \approx \frac{0.03393}{0.34299} \approx 10\% \text{ (per each side)}$$

with peak timings of

$$\begin{aligned} t_{peak} &\approx 23.7 \text{ ns} && \text{(signal)} \\ t_{peak} &\approx 12.0 \text{ ns} && \text{(crosstalk)} \end{aligned}$$



5% in current SCT digitization model

## Relevant parameters for Barrel modules

	Un-irradiated	Irradiated	ref
$C_{\text{strip}}$	> 20 pF/cm	> 20 pF/cm	[2]
$2 * C_{\text{is}}$	1.03 pF/cm	1.40 pF/cm	[1]
	< 1.1 pF/cm	< 1.5 pF/cm	[2]
$C_{\text{b}}$	0.30 pF/cm	0.30 pF/cm	[1]
$I_{\text{c}}$	220 $\mu\text{A}$	120 – 140 $\mu\text{A}$	[3]
R	1.25 $\pm$ 0.75 M $\Omega$		[2]
Strip length	126.09 – 2.090(gap) = 124.0 mm		[2]
Rf	80 k $\Omega$		[4]
Cf	120 fF		[4]
$\tau_{\text{i}}$	4 ns		[4]

[1] F. Campabadal et al., NIMA 552 (2005) 292

[2] A. Abdesselam et al., NIMA 568 (2006) 642

[3] F. Campabadal et al., NIMA 538 (2006) 384

[4] J. Kaplon (this talk)



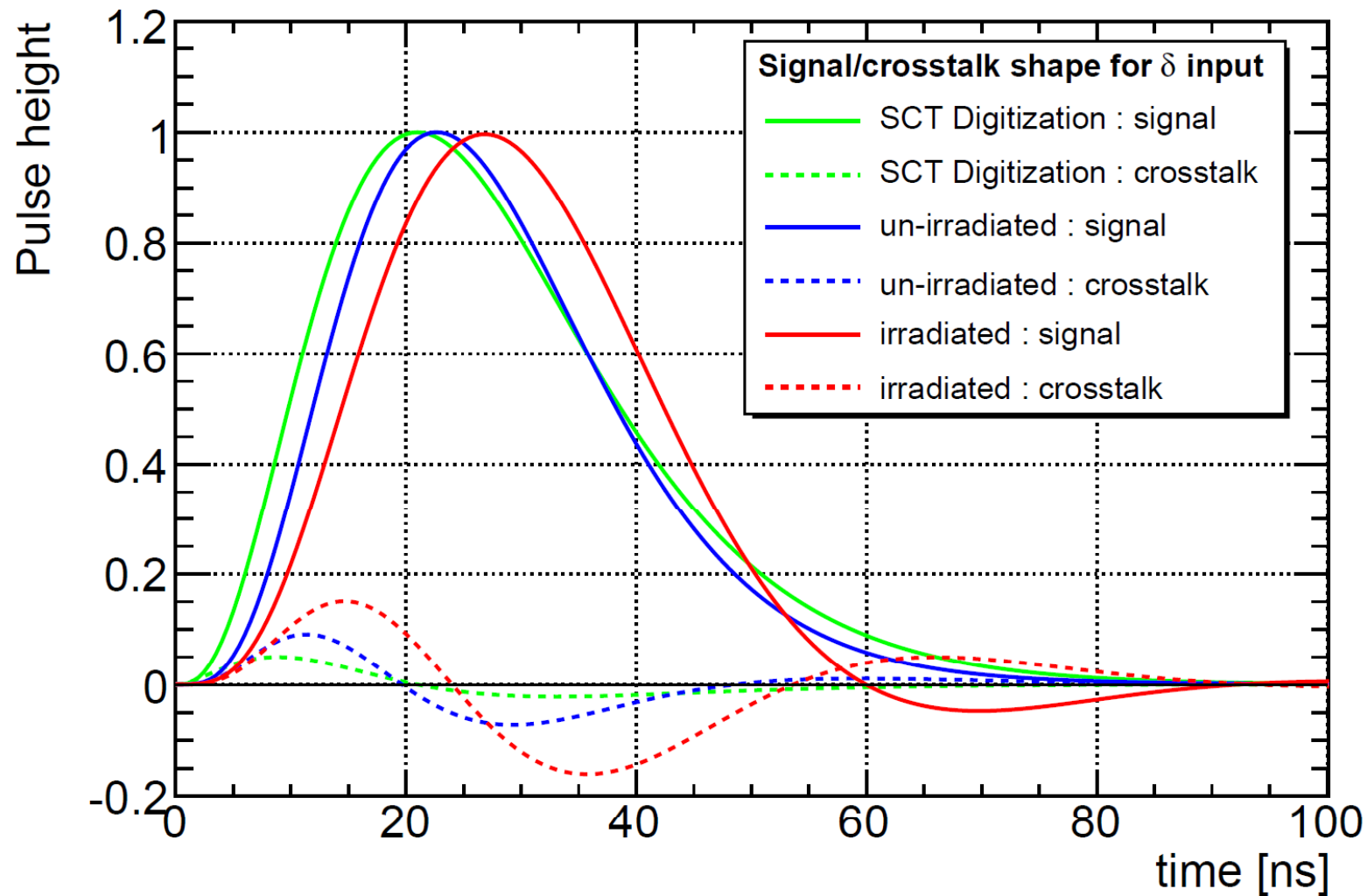
## Parameters and solutions for SCT barrel case ( t in [ns] )

	$R_f$	$\tau_f$	$\tau_i$	$C_{is}$	$C_b$	$\tau_{p0}$	$K_V$
un-irradiated	80	9.6	4	6.39	3.72	47.68	1628
Irradiated				8.68		82.33	1710
[unit]	[k $\Omega$ ]	[ns]	[ns]	[pF]	[pF]	[ns]	[V/V]

$$\begin{aligned}
 v_{signal}^{unirrad} &= \frac{0.622 \cos(0.0879t) - 9.37 \sin(0.0879t)}{e^{0.135t}} + \frac{8.77}{e^{0.104t}} - \frac{9.40 + 0.527t}{e^{0.25t}} \\
 v_{crosstalk}^{unirrad} &= \frac{0.1765}{e^{0.538t}} - \frac{0.393 \cos(0.0879t) - 5.92 \sin(0.0879t)}{e^{0.135t}} - \frac{20.15}{e^{0.124t}} + \frac{8.77}{e^{0.104t}} + \frac{11.59 + 0.872t}{e^{0.25t}} \\
 v_{signal}^{irrad} &= \frac{3.78}{e^{0.104t}} - \frac{1.82 \cos(0.0898t) + 0.986 \sin(0.0879t)}{e^{0.135t}} - \frac{1.952 + 0.125t}{e^{0.25t}} \\
 v_{crosstalk}^{irrad} &= \frac{2.90 \cos(0.0867t) - 8.27 \sin(0.0867t)}{e^{0.135t}} + \frac{3.78}{e^{0.104t}} \\
 &+ \frac{1.277 \cos(0.0898t) - 0.690 \sin(0.0898t)}{e^{0.135t}} - \frac{7.96 + 0.423t}{e^{0.25t}} \quad \text{where } t \text{ in [ns]}
 \end{aligned}$$

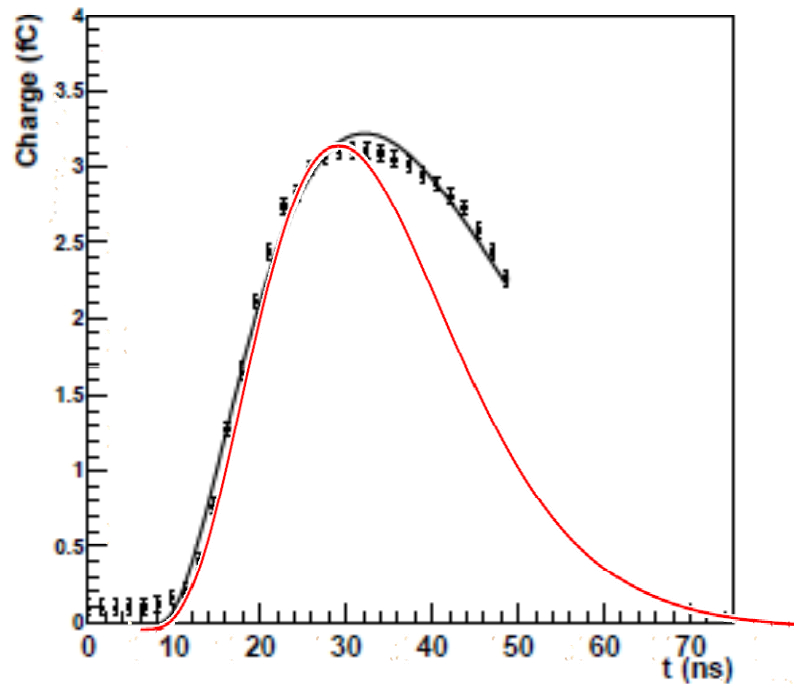
Response to  $\delta$ -function input  
 (signal peak is normalized to 1)

models	$t_{\text{peak}}$	crosstalk
SCT Digitization	21 ns	5 %
un-irradiated	22.5 ns	10 %
irradiated	27 ns	15 %

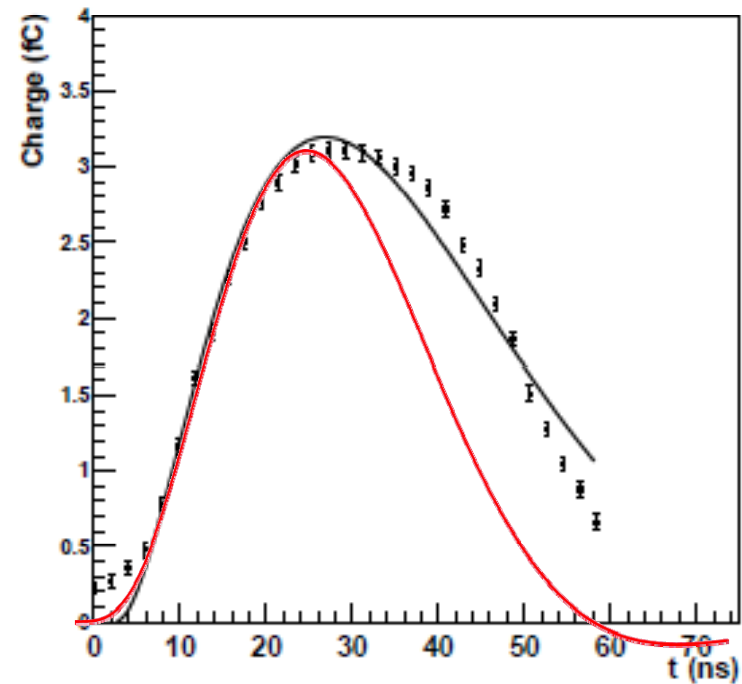


## Comparison with test beam data [1]

un-irradiated module (150V)



irradiated module (350V)



Black points: response data for calibration pulses. [1]

Red curves : present model for  $\delta$ -function input pulse.

Note that the heights were adjusted arbitrary and also the start times are shifted arbitrary for better comparison.

[1] A.J.Barr et al., ATL-INDET-2002-024 Fig. 24

## Summary

J. Kaplon provided a model for signal and crosstalk shapes based on the electrical parameters of the ABCD3T chips.

Using electrical parameters available today, the signal and crosstalk levels and shapes are calculated.

The crosstalk level is  $\sim x2$  higher (10% each side) than the current SCT Digitization model.

Comparison with calibration-pulse data indicates the rising shapes are well reproduced but not in the trailing part.